Se	arch i	Notes	

	Application/Control No.	Applicant(s)/Patent under Reexamination	
١	10/781,824	CHOI, CHANG-JUN	•
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updated	search ·	7/31/2007	MAI
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
updated search (see search history printout(s))	7/31/2007	MAI	
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